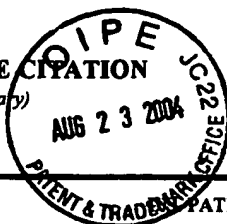


INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)

LNUP:113US

Application Number

10/823,927

Applicant(s)

Stefan THIEM et al.

Filing Date

04/14/2004

Group Art Unit

3724

PATENT DOCUMENTS

| *EXAMINER INITIAL | REF | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|----------------------|-----|-----------------|------|------|-------|----------|-------------------------------|
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U.S. PATENT APPLICATION PUBLICATIONS

| *EXAMINER INITIAL | REF | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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FOREIGN PATENT DOCUMENTS

| | REF | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
|---|-----|-----------------|------------|---------|-------|----------|-------------|----|
| | | | | | | | YES | NO |
| h | | DE4205257 | 06/03/1993 | Germany | — | — | | |
| h | | EP0937975 | 08/25/1999 | Europe | — | — | | |
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OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

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| | | Der neue Standard innovativer Mikrotomtechnik, MICROM, 1996, S. 1.2 |
| | | |

EXAMINER

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DATE CONSIDERED

9/8/06

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.